

Jochen Stahn Laboratory for Neutron Scattering ETH Zurich & Paul Scherrer Institut

Tobias PanznerLaboratory for Development and MethodsUwe FilgesPaul Scherrer Institut

study on a focusing, low-background neutron delivery system



approach:

PAUL SCHERRER INSTITUT

define the beam, starting at the sample, by:

- size at the sample position
- divergence
- wavelength, $\Delta\lambda/\lambda$

& ETH Zurich

and avoid everything else!

small samples (i.e. in the mm², mm³ range) focusing low-background

filtering / beam-profiling far from the sample

define the beam, starting at the sample

 \Rightarrow beam line lay-out

& ETH Zurich

PAUL SCHERRER INSTITUT

- shading optics
- focusing optics
 - \rightarrow aberration

application to a specular reflectometer McStas simulations on the performance

extention to diffraction / spectroscopy

next steps

prototype for amor



Amor – polarised reflectometer in TOF mode



losses between guide ($50 \times 50 \text{ mm}^2$) and sample:

- chopper: 96%
- first diaphragm: > 80%
- frame overlap filter: $\approx 5\%$
 - polariser: > 60%
- sample $(10 \times 10 \text{ mm}^2)$: 20%
 - П: > 99.75%





beam defined by • required beam divergence



beam defined by • finite source size

& **ETH** Zurich



PAUL SCHERRER INSTITUT

_

focusing



beam defined by • filtering (polarisation / monochromatisation)





beam defined by • background / radiation issues



focusing

background / radiation issues



PAUL SCHERRER INSTITUT

_

& ETH Zurich

effect of optical elements on the phase space

non-focusing elements: (*shading optics*)

- diaphragm cuts phase space
- plain mirror alters direction, λ filter
- (long) guide ", can be seen as diaphragm + translation

... limit and dilute phase space



PALL SCHERRER INSTITUT

& **ETH** Zurich



... alter and dilute phase space



monochromator

aperture

sample

realisation

& **ETH** Zurich





PAUL SCHERRER INSTITUT

=

 & ETH Zurich







coma aberration (distortion of the image of an off-axis point source)



inhomogeneous ilumination



	large α	small α	
coma effect	de-focusing	focusing	of a finite source
divergence intensity	low high	high Iow	at the sample position





0.2

0

2.5

-2

-3

-4

-2.5

-2

-1.5

-1

 α/deg

-0.5

0

-2

-3

-4

0

0.5

1

 α / deg

1.5

2



 \Rightarrow a *nice* phase space element requires a sample aperture



coma aberration

comparison to a straight guide / diaphragm set-up

guide: emmittance = $\pm 0.5^{\circ}$ slit: aperture = 2.0 mm













new McStas component

- true curvature
- all surfaces with individual properties
- individual shapes
- neutrons can pass by
- nesting of devices



to come:

- off-specular reflectivity



position monitor



divergence monitor



high-intensity specular relectomter - principle

incoming beam with known λ/α_i relation

& **ETH** Zurich

PALL SCHERRER INSTITUT



detection of *I* vs. α_f

conversion to $q_Z = 4\pi \frac{\sin \alpha_f}{\lambda}$

gain:

 $\Delta \alpha_i = 1.4^{\circ}$ compared to $\Delta \alpha / \alpha = 7\%$ gives a gain factor 20

but:

off-specular scattering leads to background

 \Rightarrow method is limited to 5 orders of magnitude



high-intensity specular relectomter – implementation

ReFOCUS concept by F. Ott





McStas simulations for selene — reflectometer using a double **ml monochromator** (m = 3)

incident angle on the ml: $0 \dots 2^{\circ}$ with $\lambda \propto \sin \alpha_i$

acceptance of the guide: $\Delta \alpha = 1.3^{\circ}$

 $\Rightarrow \lambda$ vs. α_i at sample position:



McStas simulations for selene — reflectometer using a double ml monochromator m = 6, $\Delta q_Z/q_Z \approx 1\%$

& **ETH** Zurich



no off-specular scattering included, yet



McStas simulations for selene — reflectometer using a double ml monochromator m = 5, $\Delta q_Z/q_Z = 7\%$





McStas simulations for selene — reflectometer using a double ml monochromator m = 3, $\Delta q_Z/q_Z \approx 4\%$





McStas simulations for selene — reflectometer using a double PG monochromator ($\Delta \alpha = 0.16^{\circ}$)



no illumination correction applied yet



McStas simulations for selene — reflectometer using a double PG monochromator

comparison: mosaicity of PG



McStas simulations for selene — reflectometer using a double PG monochromator ($\Delta \alpha = 0.16^{\circ}$)

comparison: sample sizes $10 \times 10 \,\text{mm}^2$ $8 \times 8 \,\text{mm}^2$ 2 $6 \times 6 \,\text{mm}^2$ $4 \times 4 \text{ mm}^2$ $2 \times 2 \, mm^2$ $\log_{10}[I(q_Z)]$ 0 -2 -3 -4 0.04 0.05 0.06 0.07 0.08 0.03 $q_Z/\text{\AA}^{-1}$

PAUL SCHERRER INSTITUT

& **ETH** Zurich



reflectometer – resumee

maximum flux on the sample fo a given $\Delta \alpha_i$

allows for high-intensity reflectometry:

- ml monochromator: q_z -range e.g. 0.01 to 0.1 Å⁻¹
- PG monochromator: q_z -range $\propto \Delta \alpha_i$

reduction of $\Delta \alpha_i$ leads to a *conventional* angle-dispersive reflectometer

- \Rightarrow off-specular measurements are possible
- \Rightarrow a diaphragm-scan results in a q_z -scan







typical set-up:

source – guide – monochromator – sample



monochromator: array of flat crystals (mirrors)

 \Rightarrow divergence is transported



modified set-up:

source – guide – monochromator + lense – sample



lense: mirror with continuous curvature

 \Rightarrow divergence is transformed to convergence



modified set-up:

source - short guide - monochromator - aperture - lense - sample



aperture: reduces un-wanted flux

 \Rightarrow reduced background



modified set-up:

source – short guide – monochromator – aperture – lense – sample



guide: reduced to the necessary length

- \Rightarrow **selene**-type set-up
- double monochromator needed
- same usable intensity on the sample
- + strongly reduced background
- + fix sample position

McStas simulations for selene

— diffractometer

& **ETH** Zurich

PAUL SCHERRER INSTITUT

using a double **PG monochromator**







next steps

PAUL SCHERRER INSTITUT

a prototype of 4 m length (monochromator to sample) is under construction

& **ETH** Zurich

to be tested on **BOA**



to be used on AMOR

selene



Amor – polarised reflectometer in TOF mode





Amor with selene in TOF mode



horizontal focusing a_{2} in factor ~ 6

gain factor ≈ 6

enables high-intensity specular reflectivity gain factor ≈ 20



Amor with selene in monochromator mode



chopper stopped double monochromator (ml or PG)

same flux, but different q_z -range

polarising ml possible

PAUL SCHERRER INSTITUT

replacement of the guide of e.g. RITAII, SINQ

- old insert / first part of the straight guide can be reused

monochromator in the 1st part of guide bunker

- guide ends within guide bunker



- \Rightarrow fixed sample position
- \Rightarrow large 2 θ -range accessible



filter first:

& **ETH** Zurich

PAUL SCHERRER INSTITUT

- + reduction of radiation entering the guide to <1%
- + reduced n-background: saves shielding material
- + reduced radiation level: saves life!
- no gain in flux!
- mechanical parts close to source

focusing guide:

- + reduces illumination of sample sourroundings
- + no direct view to source
- + allows for small monochromators . . .
- $\circ\,$ no gain in flux!
- + allows for q_z/α_i encoding
- (coma) aberration
- does not work for *large* samples



thanks to

- T. Panzner and U. Filges
 - for the McStas programmig and simulation work
- C. Marcelot and L. Holitzner
 - for support in the test and design process

- F. Ott
 - for the ReFOCUS concept which triggered this work
- P. Böni, U. Stuhr and C. Niedermayer
- for long discussions
- nmi3, MaNEP, SNF and SwissNeutronics for financial and technical support

YOU